

Maximum Ratings, 2222A Type (NPN) (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Unit
Collector-Base Voltage	V _{CBO}	75	V
Collector-Emitter Voltage	V _{CEO}	40	V
Emitter-Base Voltage	V _{EBO}	6	V
Continuous Collector Current	Ic	600	mA

Maximum Ratings, 2907A Type (PNP) (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Unit
Collector-Base Voltage	V _{CBO}	-60	V
Collector-Emitter Voltage	V _{CEO}	-60	V
Emitter-Base Voltage	V _{EBO}	-6.0	V
Continuous Collector Current	Ic	-600	mA

Thermal Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic		Symbol	Value	Unit
Power Dissipation	(Notes 5)	P _D	200	mW
Thermal Resistance, Junction to Ambient	(Notes 5)	$R_{ heta JA}$	625	°C/W
Thermal Resistance, Junction to Case	(Note 6)	$R_{ heta JC}$	150	-C/vv
Operating and Storage Temperature Range		T _J , T _{STG}	-55 to +150	°C

Notes:

^{5.} Device mounted on 1 inch x 0.85 inch x 0.062 inch FR-4 PCB

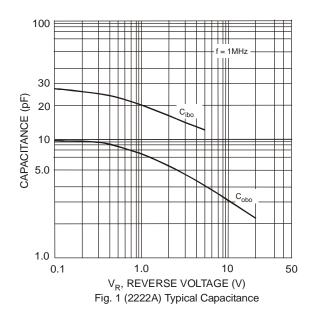
^{6.} Thermal resistance from junction to the top of package



Electrical Characteristics, 2222A Type (NPN) (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 7)					
Collector-Base Breakdown Voltage	BV _{CBO}	75		٧	$I_C = 100 \mu A, I_E = 0$
Collector-Emitter Breakdown Voltage	BV _{CEO}	40		V	$I_C = 10 \text{mA}, I_B = 0$
Emitter-Base Breakdown Voltage	BV _{EBO}	6.0		V	$I_E = 100 \mu A, I_C = 0$
Collector Cutoff Current	I _{CBO}		10	nA μA	$V_{CB} = 60V, I_E = 0$ $V_{CB} = 60V, I_E = 0, T_A = +150^{\circ}C$
Collector Cutoff Current	I _{CEX}		10	nA	$V_{CE} = 60V, V_{EB(off)} = 3.0V$
Emitter Cutoff Current	I _{EBO}		10	nA	V _{EB} = 5.0V, I _C = 0
Base Cutoff Current	I _{BL}		20	nA	$V_{CE} = 60V$, $V_{EB(off)} = 3.0V$
ON CHARACTERISTICS (Note 7)					` '
DC Current Gain	h _{FE}	35 50 75 100 40 50 35	300		$\begin{array}{ll} I_{C} = 100 \mu A, \ V_{CE} = 10V \\ I_{C} = 1.0 mA, \ V_{CE} = 10V \\ I_{C} = 10 mA, \ V_{CE} = 10V \\ I_{C} = 150 mA, \ V_{CE} = 10V \\ I_{C} = 500 mA, \ V_{CE} = 10V \\ I_{C} = 10 mA, \ V_{CE} = 10V, \ T_{A} = -55^{\circ}C \\ I_{C} = 150 mA, \ V_{CE} = 1.0V \end{array}$
Collector-Emitter Saturation Voltage	V _{CE(sat)}	_	0.3 1.0	V	$I_C = 150 \text{mA}, I_B = 15 \text{mA}$ $I_C = 500 \text{mA}, I_B = 50 \text{mA}$
Base-Emitter Saturation Voltage	V _{BE(sat)}	0.6	1.2 2.0	٧	$I_C = 150 \text{mA}, I_B = 15 \text{mA}$ $I_C = 500 \text{mA}, I_B = 50 \text{mA}$
SMALL SIGNAL CHARACTERISTICS					
Output Capacitance	C_{obo}		8	pF	$V_{CB} = 10V, f = 1.0MHz, I_{E} = 0$
Input Capacitance	C_{ibo}		25	pF	$V_{EB} = 0.5V$, $f = 1.0MHz$, $I_{C} = 0$
Current Gain-Bandwidth Product	f⊤	300		MHz	$V_{CE} = 20V$, $I_C = 20mA$, $f = 100MHz$
Noise Figure	NF	_	4.0	dB	V_{CE} = 10V, I_{C} = 100μA, R_{S} = 1.0kΩ, f = 1.0kHz
SWITCHING CHARACTERISTICS					
Delay Time	t _d	_	10	ns	$V_{CC} = 30V, I_{C} = 150mA,$
Rise Time	t _r	_	25	ns	$V_{BE(off)} = -0.5V, I_{B1} = 15mA$
Storage Time	ts		225	ns	$V_{CC} = 30V, I_C = 150mA,$
Fall Time	t _f	_	60	ns	$I_{B1} = I_{B2} = 15mA$

7. Pulse test: Pulse width $\leq 300 \mu s$, duty cycle $\leq 2\%$. Notes:



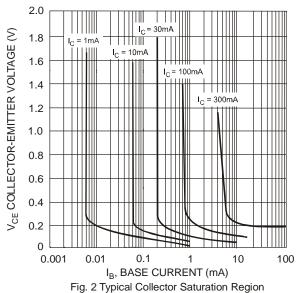


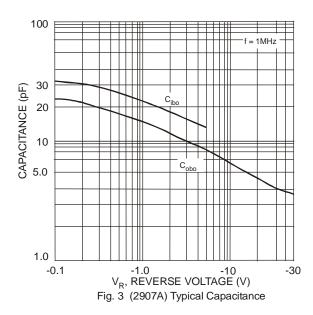
Fig. 2 Typical Collector Saturation Region (2222A Type - NPN)

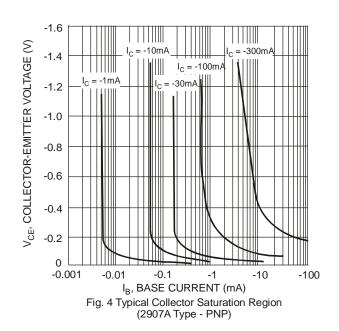


Electrical Characteristics, 2907A Type (PNP) (@TA = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 8)					
Collector-Base Breakdown Voltage	BV _{CBO}	-60	_	V	$I_C = -100 \mu A, I_E = 0$
Collector-Emitter Breakdown Voltage	BV _{CEO}	-60		٧	$I_C = -10 \text{mA}, I_B = 0$
Emitter-Base Breakdown Voltage	BV _{EBO}	-6.0		V	$I_E = -100 \mu A, I_C = 0$
Collector Cutoff Current	I _{CBO}		-10	nA	$V_{CB} = -50V, I_{E} = 0$
	ICBO		-10	μΑ	$V_{CB} = -50V, I_E = 0, T_A = +125^{\circ}C$
Collector Cutoff Current	I _{CEX}		-50	nA	$V_{CE} = -30V, V_{EB(off)} = -0.5V$
Base Cutoff Current	I_{BL}	_	-50	nA	$V_{CE} = -30V, V_{EB(off)} = -0.5V$
ON CHARACTERISTICS (Note 8)					
		75	_		$I_C = -100 \mu A, V_{CE} = -10 V$
		100	_		$I_C = -1.0 \text{mA}, V_{CE} = -10 \text{V}$
DC Current Gain	h _{FE}	100	_	_	$I_C = -10 \text{mA}, V_{CE} = -10 \text{V}$
		100	300		$I_C = -150 \text{mA}, V_{CE} = -10 \text{V}$
		50			$I_C = -500 \text{mA}, V_{CE} = -10 \text{V}$
Collector-Emitter Saturation Voltage	V		-0.4	V	$I_C = -150 \text{mA}, I_B = -15 \text{mA}$
Collector-Emitter Saturation Voltage	V _{CE(sat)}		-1.6	V	$I_C = -500 \text{mA}, I_B = -50 \text{mA}$
Base-Emitter Saturation Voltage	V _{BE(sat)}		-1.3	V	$I_C = 150 \text{mA}, I_B = 15 \text{mA}$
	VBE(sat)		-2.6	v	$I_C = 500 \text{mA}, I_B = 50 \text{mA}$
SMALL SIGNAL CHARACTERISTICS					
Output Capacitance	C _{obo}		8.0	pF	$V_{CB} = -10V$, $f = 1.0MHz$, $I_E = 0$
Input Capacitance	C _{ibo}	_	30	pF	$V_{EB} = -2.0V$, $f = 1.0MHz$, $I_{C} = 0$
Current Gain-Bandwidth Product	f _T	200		MHz	$V_{CE} = -20V, I_{C} = -50mA,$ f = 100MHz
SWITCHING CHARACTERISTICS					
Turn-On Time	t _{on}		45	ns	_
Delay Time	t _d	_	10	ns	$V_{CC} = -30V, I_{C} = -150mA,$
Rise Time	t _r		40	ns	$I_{B1} = -15 \text{mA}$
Turn-Off Time	t _{off}	_	100	ns	_
Storage Time	t _s		80	ns	$V_{CC} = -6.0V$, $I_{C} = -150mA$,
Fall Time	t _f		30	ns	$I_{B1} = I_{B2} = -15 \text{mA}$

Notes: 8. Short duration pulse test used to minimize self-heating effect.

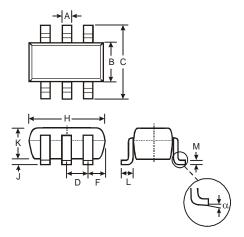






Package Outline Dimensions

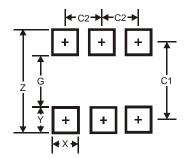
Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for latest version.



	SOT363					
Dim	Min	Max	Тур			
Α	0.10	0.30	0.25			
В	1.15	1.35	1.30			
С	2.00	2.20	2.10			
D		0.65 Typ				
F	0.40	0.45	0.425			
Н	1.80	2.20	2.15			
J	0	0.10	0.05			
K	0.90	1.00	1.00			
L	0.25	0.40	0.30			
М	0.10	0.22	0.11			
α	0°	8°	-			
All	All Dimensions in mm					

Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



Dimensions	Value (in mm)
Z	2.5
G	1.3
Х	0.42
Υ	0.6
C1	1.9
C2	0.65



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6 of 6

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